

EMC COMPLIANCE TEST REPORT

for

LCD Monitor

Trade Name : COMPAL; AG neovo

Model Number : GM678; F-417

Serial Number : N/A

Report Number: 030355-E

Date : April 29, 2003

Regulations : See below

Standards	Results (Pass/Fail)
EN 55022: 1998	PASS
EN 61000-3-2: 1995 + A1: 1998 + A2: 1998	PASS
EN 61000-3-3: 1995	PASS
EN 55024: 1998	PASS
- IEC 61000-4-2: 2001	PASS
- IEC 61000-4-3: 1995	PASS
- IEC 61000-4-4: 1995	PASS
- IEC 61000-4-5: 1995	PASS
- IEC 61000-4-6: 1996	PASS
- IEC 61000-4-8: 1993	PASS
- IEC 61000-4-11: 1994	PASS

Prepared for:

Compal Electronics Inc. No. 581, Jui Kuang Rd., Neihu, Taipei, (114) Taiwan, R.O.C.

Prepared by:



C&C LABORATORY, CO., LTD.

No. 81-1, 210 Lane, Pa-de 2nd Road, Lu-Chu Hsiang, Taoyuan, Taiwan, R.O.C.

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EC-Declaration of Conformity

For the following equipment:

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(Product Name)

GM678; F-417 / COMPAL; AG neovo

(Model Designation / Trade name)

- 1.) Compal Electronics Inc.
- 2.) Compal Electronics (China) Co., Ltd.

(Manufacturer Name)

- 1.) No. 8, Nan-Tung Rd., Pin-Cheng City, Tao-Yuan Hsien, Taiwan, R.O.C.
- 2.) No. 988, Tung Fen East Rd., Economic & Technical Development Zone Kunshan, Jiangsun, P.R. China

(Manufacturer Address)

is herewith confirmed to comply with the requirements set out in the Council Directive on the Approximation of the Laws of the Member States relating to Electromagnetic Compatibility Directive (89/336/EEC, Amended by 92/31/EEC, 93/68/EEC & 98/13/EC), For the evaluation regarding the Electromagnetic Compatibility (89/336/EEC, Amended by 92/31/EEC, 93/68/EEC & 98/13/EC), the following standards are applied:

V EN 55022: 1998
 V EN 61000-3-2: 1995 + A1: 1998 + A2: 1998
 V EN 61000-3-3: 1995
 V EN 55024: 1998

IEC 61000-4-2: 2001; IEC 61000-4-3: 1995; IEC 61000-4-4: 1995; IEC 61000-4-5: 1995; IEC 61000-4-6: 1996; IEC 61000-4-8: 1993; IEC 61000-4-11: 1994

The following manufacturer / importer or authorized representative established within the EUT is responsible for this declaration:

(Company Name)			
(Company Address)			
Person responsible for m	aking this declaration:		
(Name, Surname)			
(Position / Title)			
(Place)	(Date)	(Legal Signature)	



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1 VERIFICATION OF COMPLIANCE

Equipment Under Test: LCD Monitor

Trade Name: COMPAL; AG neovo

Model Number: GM678; F-417

Serial Number: N/A

Applicant: Compal Electronics Inc.

No. 581, Jui Kuang Rd., Neihu, Taipei, (114) Taiwan, R.O.C.

Manufacturer: 1.) Compal Electronics Inc.

No. 8, Nan-Tung Rd., Pin-Cheng City, Tao-Yuan Hsien, Taiwan, R.O.C.

2.) Compal Electronics (China) Co., Ltd.

No. 988, Tung Fen East Rd., Economic & Technical Development Zone

Kunshan, Jiangsun, P.R. China

Type of Test: EMC Directive 89/336/EEC for CE Marking

Technical Standards: EN 55022: 1998

EN 61000-3-2: 1995 + A1: 1998 + A2: 1998

EN 61000-3-3: 1995

EN 55024: 1998 (IEC 61000-4-2: 2001, IEC 61000-4-3: 1995,

IEC 61000-4-4: 1995, IEC 61000-4-5: 1995, IEC 61000-4-6: 1996, IEC 61000-4-8: 1993,

IEC 61000-4-11: 1994)

File Number: 030355-E

Date of Test: April 24 ~ 26, 2003

Deviation:NoneCondition of Test Sample:NormalFinal Result:Pass

Worst Data: See below

Test Item	Freq. (MHz)	Measured Data	Margin (MμC)	Remark
Radiated Emission	179.76	27.7 (dB/m)	-2.3 dB (± 3.3498 dB)	
Conducted Emission	0.155	42.3 (dB)	-23.4dB (± 2.8104 dB)	

- The negative sign in Margin cell means under the specific limit.
- This test result traceable to national or international standards.

The above equipment was tested by C&C Laboratory Co., Ltd. for compliance with the requirements set forth in EMC Directive 89/336/EEC and the Technical Standards mentioned above. This said equipment in the configuration described in this report shows the maximum emission levels emanating from equipment and the level of the immunity endurance of the equipment are within the compliance requirements.

The test results of this report relate only to the tested sample identified in this report.

Approved by:

Reviewed by:

Jonson Lee / EMC Director

Susan Su / Section Manager

GENERAL INFORMATION 2

Applicant: Compal Electronics Inc.

No. 581, Jui Kuang Rd., Neihu, Taipei, (114) Taiwan, R.O.C.

Contact Person: Wilson Pan

Manufacturer: 1). Compal Electronics Inc.

No. 8, Nan-Tung Rd., Pin-Cheng City, Tao-Yuan Hsien, Taiwan, R.O.C.

2). Compal Electronics (China) Co., Ltd.

No. 988, Tung Fen East Rd., Economic & Technical Development Zone

Kunshan, Jiangsun, P.R. China

File Number: 030355-E

Date of Test: April 24 ~ 26, 2003

Equipment Under Test: LCD Monitor

GM678; F-417 **Model Number:**

Serial Number: N/A

Type of Test: EMC Directive 89/336/EEC for CE Marking

Technical Standards: EN 55022: 1998

EN 61000-3-2: 1995 + A1: 1998 + A2: 1998

EN 61000-3-3: 1995

EN 55024: 1998 (IEC 61000-4-2: 2001, IEC 61000-4-3: 1995,

> IEC 61000-4-4: 1995, IEC 61000-4-5: 1995, IEC 61000-4-6: 1996, IEC 61000-4-8: 1993,

IEC 61000-4-11: 1994)

Frequency Range

150kHz to 30MHz for Line Conducted Test (EN 55022): 30MHz to 1000MHz for Radiated Emission Test

C&C LABORATORY CO., LTD. Test Site:

No. 81-1, 210 Lane, Pa-de 2nd Road, Lu-Chu Hsiang,

Taoyuan, Taiwan, R.O.C.

3 SYSTEM DESCRIPTION

EUT Test Program:

- 1. EMI test program was loaded and executed in Windows 98 mode.
- 2. Data was sent to EUT filling the screen with upper case of "H" patterns.
- 3. Test program sequentially exercised printer and modem, then sent "H" patterns to them individually.
- 4. Repeat 2 to 3. Test program is self-repeating throughout the test.

4 PRODUCT INFORMATION

Housing Type: Plastic

EUT Power Rating: 100~240VAC, 50 / 60Hz

AC power during Test: 230VAC/ 50Hz

AC Power Cord Type: Unshielded, 1.8m (Detachable)

OSC/Clock Frequencies: 14.318MHz

LCD Panel Manufacturer: Hyundai Model: HT17E12-200

Power Board Manufacturer:COMPALModel:VP-719Main Board Manufacturer:COMPALModel:VL-720Key Board Manufacturer:COMPALModel:VK-718

VGA Cable Type: Shielded, 1.8m (Non-detachable) with two cores

I/O Port of EUT

I/O Port Type	Q'TY	Tested with
1). Video Out Port (VGA)	1	1

Note: The differences between of two model numbers (list on this report) are identical, just for marketing purpose only.



5 SUPPORT EQUIPMENT

No.	Equipment	Model #	Serial #	FCC ID	Trade Name	Data Cable	Power Cord
1.	PC	EVO D300	6K1BKF83F18F	FCC DoC	Compaq	N/A	Unshielded, 1.8m
2.	Modem	2400	94-364-176277	DK467GSM24	Computer Peripherals	Shielded, 1.8m	Unshielded, 1.8m
3.	Printer	EPSON STYLUS C20SX	DW4E130540	FCC DoC	EPSON	Shielded, 1.8m	Unshielded, 1.8m
4.	PS/2 Keyboard	SK-2800C	B1C790BCPJCN6L	GYUR79SK	Compaq	Shielded, 1.8m	N/A
5.	PS/2 Mouse	M-CAA43	LZA11750827	FCC DoC	Logitech	Shielded, 1.8m	N/A

Note: All the above equipment/cables were placed in worse case positions to maximize emission signals during emission test.

Grounding: Grounding was in accordance with the manufacturer's requirements and conditions for the intended use.

6 TEST FACILITY

Location: No. 81-1, 210 Lane, Pa-de 2nd Road, Lu-Chu Hsiang, Taoyuan,

Taiwan, R. O. C.

Description: There are four 3/10m open area test sites and three line conducted

labs for final test. The Open Area Test Sites and the Line Conducted labs are constructed and calibrated to meet the FCC requirements in documents ANSI C63.4: 2001 and CISPR 16

requirements.

Site Filing: A site description is on file with the Federal Communications

Commission, 7435 Oakland Mills Road, Columbia, MD 21046.

Registration also was made with Voluntary Control Council for

Interference (VCCI).

Site Accreditation: Accredited by NEMKO (Authorization #: ELA 124) for EMC &

A2LA (Certificate #: 824.01) for Emission

Accredited by NVLAP (Certificate #: 200600-0)

Also accredited by BSMI for the product category of Information

Technology Equipment.

Instrument Tolerance: All measuring equipment is in accord with ANSI C63.4 and CISPR

22 requirements that meet industry regulatory agency and

accreditation agency requirement.

Ground Plane: Two conductive reference ground planes were used during the Line Conducted Emission, one in vertical and the other in horizontal. The dimensions of these ground planes are as below. The vertical ground plane was placed distancing 40 cm to the rear of the wooden test table on where the EUT and the support equipment were placed during test. The horizontal ground plane projected 50 cm beyond the footprint of the EUT system and distanced 80 cm to the wooden test table. For Radiated Emission Test, one horizontal conductive ground plane extended at least 1m beyond the periphery of the EUT and the largest measuring antenna, and covered the entire area between the EUT and the antenna. It has no holes or gaps having longitudinal dimensions larger than one-tenth of a wavelength at the highest frequency of measurement up to 1GHz.

Site # 3 & # 4 Line Conducted Test Site: At Shielding Room



7 TEST EQUIPMENT LIST (EMISSION)

Instrumentation: The following list contains equipment used at C & C Laboratory, Co., Ltd. for testing. The equipment conforms to the CISPR 16-1 / ANSI C63.2-1988 Specifications for Electromagnetic Interference and Field Strength Instrumentation from 9kHz to 1.0 / 2.0 GHz. **Equipment used during the tests:**

Open Area Test Site: #1

Open Area Test Site # 1								
EQUIPMENT TYPE	MFR	MODEL NUMBER	SERIAL NUMBER	LAST CAL.	CAL. DUE			
Spectrum Analyzer	HP	8568B	3001A05004	07/03/2002	07/02/2003			
S.P.A Display	HP	85662A	3014A18846	07/03/2002	07/02/2003			
Q.P Adaptor	HP	85650A	2811A01399	07/03/2002	07/02/2003			
RF Pre-selector	HP	85685A	2947A01064	07/03/2002	07/02/2003			
Spectrum Analyzer	Anritsu	MS2601A	MT09950	N/A	N/A			
Pre-Amplifier	HP	8447D	2944A08432	N/A	N/A			
Bilog Antenna	CHASE	CBL6112A	2309	02/28/2003	02/27/2004			
Turn Table	EMCO	2081-1.21	N/A	N.C.R	N.C.R			
Antenna Tower	EMCO	2075-2	9707-2604	N.C.R	N.C.R			
Controller	EMCO	2090	N/A	N.C.R	N.C.R			
RF Switch	ANRITSU	MP59B	M54367	N.C.R	N.C.R			
Site NSA	C&C	N/A	N/A	08/31/2002	08/30/2003			

Conducted Emission Test Site: #3

Conducted Emission Test Site # 3								
EQUIPMENT	MFR	MODEL	SERIAL	LAST	CAL.			
TYPE	MIFK	NUMBER	NUMBER	CAL.	DUE			
EMI Test Receiver	R&S	ESHS30	828144/003	08/08/2002	08/07/2003			
LISN	R&S	ENV 4200	830326/016	03/05/2003	03/04/2004			
LISN	EMCO	3825/2	9003/1382	02/26/2003	02/25/2004			

Power Harmonic & Voltage Fluctuation/Flicker Measurement:

Power Harmonic & Voltage Fluctuation/Flicker Measurement (61000-3-2&-3-3)								
EQUIPMENT TYPE	MFR	MODEL NUMBER	SERIAL NUMBER	LAST CAL.	CAL DUE.			
Harmonic & Flicker Tester	HAEFELY TRENCH	PHF555	080 419-25	10/14/2002	10/13/2003			

The calibrations of the measuring instruments, including any accessories that may effect such calibration, are checked frequently to assure their accuracy. Adjustments are made and correction factors applied in accordance with instructions contained in the manual for the measuring instrument.



8 TEST EQUIPMENT LIST (IMMUMITY)

ESD test (61000-4-2)										
EQUIPMENT TYPE	MFR	MODEL NUMBER	SERIAL NUMBER	LAST CAL.	CAL DUE.					
ESD Generator	EM TEST	P30C-RFCI	0603-011	02/27/2003	02/26/2004					
Radia	Radiated Electromagnetic Field immunity Measurement (61000-4-3)									
EQUIPMENT TYPE	MFR	MODEL NUMBER	SERIAL NUMBER	LAST CAL.	CAL DUE.					
S.G.	R&S	SMY02	100094	08/08/2002	08/07/2003					
Power Amplifier	ar	150W1000	300300	N/A	N/A					
Power Antenna	EMCO	93141	9712-1083	N/A	N/A					
EM PROBE	GW	EMR-30	L-0013	05/23/2002	05/22/2003					
	Fast Trans	sients/Burst test (6	51000-4-4)							
EQUIPMENT TYPE	MFR	MODEL NUMBER	SERIAL NUMBER	LAST CAL.	CAL DUE.					
Fast Transients/Burst Generator	HAEFELY TRENCH	PEFT- JUNIOR	583 333-117	08/22/2002	08/21/2003					
	Surge I	mmunity test (610	00-4-5)							
EQUIPMENT TYPE	MFR	MODEL NUMBER	SERIAL NUMBER	LAST CAL.	CAL DUE.					
Surge Tester	HAEFELY TRENCH	PSUGER 4010	583 334-71	09/03/2002	09/02/2003					
	(CS test (61000-4-6)								
EQUIPMENT TYPE	MFR	MODEL NUMBER	SERIAL NUMBER	LAST CAL.	CAL DUE.					
S.G.	R&S	SMY02	100094	08/08/2002	08/07/2003					
Power Amplifier	ar	500A100A	300299	N/A	N/A					
CDN	Lüthi	801-M3	1879	02/26/2003	02/25/2004					
CDN	MEB	M2	A3002010	04/24/2002	04/23/2003					
P	ower Frequency Ma	gnetic Field Imm	unity test (61000-	4-8)						
EQUIPMENT TYPE	MFR	MODEL NUMBER	SERIAL NUMBER	LAST CAL.	CAL DUE.					
TRIAX ELF Magnetic Field Meter	F.W.BELL	4090	9711	10/21/2002	10/20/2003					
Magnetic Field Tester	HAEFELY TRENCH	MAG 100.1	080 938-01	N/A	N/A					
Voltage Dips	s/Short Interruption	and Voltage Varia	tion Immunity to	est (61000-4-11)						
EQUIPMENT TYPE	MFR	MODEL NUMBER	SERIAL NUMBER	LAST CAL.	CAL DUE.					
Dips/Interruption and Variations Simulator	HAEFELY TRENCH	PLINE 1610	080 344-05	03/28/2003	03/27/2004					

9 SECTION 1 EN 55022 (LINE CONDUCTED & RADIATED EMISSION)

9.1 MEASUREMENT PROCEDURE (PRELIMINARY LINE CONDUCTED EMISSION TEST)

- 1) The equipment was set up as per the test configuration to simulate typical actual usage per the user's manual. When the EUT is a tabletop system, a wooden table with a height of 0.8 meters is used and is placed on the ground plane as per EN 55022 (see Test Facility for the dimensions of the ground plane used). When the EUT is a floor-standing equipment, it is placed on the ground plane which has a 3-12 mm non-conductive covering to insulate the EUT from the ground plane.
- 2) Support equipment, if needed, was placed as per EN 55022.
- 3) All I/O cables were positioned to simulate typical actual usage as per EN 55022.
- 4) The EUT received AC power through a Line Impedance Stabilization Network (LISN) which supplied power source and was grounded to the ground plane.
- 5) All support equipment received power from a second LISN supplying power of 110VAC/60Hz, if any.
- 6) The EUT test program was started. Emissions were measured on each current carrying line of the EUT using a spectrum analyzer / Receiver connected to the LISN powering the EUT. The LISN has two monitoring points: Line 1 (Hot Side) and Line 2 (Neutral Side). Two scans were taken: one with Line 1 connected to Analyzer / Receiver and Line 2 connected to a 50 ohm load; the second scan had Line 1 connected to a 50 ohm load and Line 2 connected to the Analyzer / Receiver.
- 7) Analyzer / Receiver scanned from 150kHz to 30MHz for emissions in each of the test modes.
- 8) During the above scans, the emissions were maximized by cable manipulation.
- 9) The following test mode(s) were scanned during the preliminary test:

Mode(s):

- 1. 1280×1024 Resolution 75Hz
- 2. 1024×768 Resolution 75Hz
- 3. 800×600 Resolution 75Hz
- 10) After the preliminary scan, we found the following test mode producing the highest emission level.

Mode: 1.

Then, the EUT configuration and cable configuration of the above highest emission level were recorded for reference of final testing.



MEASUREMENT PROCEDURE (FINAL LINE CONDUCTED EMISSION TEST)

- 1) EUT and support equipment was set up on the test bench as per step 10 of the preliminary test.
- 2) A scan was taken on both power lines, Line 1 and Line 2, recording at least the six highest emissions. Emission frequency and amplitude were recorded into a computer in which correction factors were used to calculate the emission level and compare reading to the applicable limit. If EUT emission level was less –2dB to the A.V. limit in Q.P. mode, then the emission signal was re-checked using an A.V. detector.
- 3) The test data of the worst case condition(s) was reported on the Summary Data page.

Data Sample:

Freq. MHz	Q.P. Raw dBuV	Average Raw dBuV	Q.P. Limit dBuV	Average Limit dBuV	Q.P. Margin dB	Average Margin dB	Note
x.xx	43.95		56	46	-12.05		L1

Freq. = Emission frequency in MHz

Raw dBuV = Uncorrected Analyzer/Receiver reading +

Insertion loss of LISN, if it > 0.5 dB

Limit dBuV = Limit stated in standard

Margin dB = Reading in reference to limit

Note = Current carrying line of reading

"---" = The emission level complied with the Average

limits, with at least 2dB margin limits, so no

further recheck.

Calculation example:

Margin (dB) = RAW (dBuV) - Limit (dBuV)

LINE CONDUCTED EMISSION LIMIT (EN 55022)

Eraguanov	Maximum RF Line Voltage		
Frequency	Q.P.	AVERAGE	
150kHz-500kHz	66-56dBuV	56-46dBuV	
500kHz-5MHz	56dBuV	46dBuV	
5MHz-30MHz	60dBuV	50dBuV	

Note: The lower limit shall apply at the transition frequency.

9.2 MEASUREMENT PROCEDURE (PRELIMINARY RADIATED EMISSION TEST)

- 1) The equipment was set up as per the test configuration to simulate typical actual usage per the user's manual. When the EUT is a tabletop system, a wooden turntable with a height of 0.8 meters is used which is placed on the ground plane as per EN 55022 (see Test Facility for the dimensions of the ground plane used). When the EUT is a floor-standing equipment, it is placed on the ground plane which has a 3-12 mm non-conductive covering to insulate the EUT from the ground plane.
- 2) Support equipment, if needed, was placed as per EN 55022.
- 3) All I/O cables were positioned to simulate typical actual usage as per EN 55022.
- 4) The EUT received AC power source from the outlet socket under the turntable. All support equipment received 110VAC/60Hz power from another socket under the turntable, if any.
- 5) The antenna was placed at 10 meter away from the EUT as stated in EN 55022. The antenna connected to the Analyzer via a cable and at times a pre-amplifier would be used.
- 6) The Analyzer / Receiver quickly scanned from 30MHz to 1000MHz. The EUT test program was started. Emissions were scanned and measured rotating the EUT to 360 degrees and positioning the antenna 1 to 4 meters above the ground plane, in both the vertical and the horizontal polarization, to maximize the emission reading level.
- 7) The following test mode(s) were scanned during the preliminary test:

Mode(s):

- 1. 1280 × 1024 Resolution 75Hz
- 2. 1024×768 Resolution 75Hz
- 3. 800×600 Resolution 75Hz
- 8) After the preliminary scan, we found the following test mode producing the highest emission level.

Mode: 1.

Then, the EUT and cable configuration, antenna position, polarization and turntable position of the above highest emission level were recorded for final testing.



MEASUREMENT PROCEDURE (FINAL RADIATED EMISSION TEST)

- 1) EUT and support equipment were set up on the turntable as per step 8 of the preliminary test.
- 2) The Analyzer / Receiver scanned from 30MHz to 1000MHz. Emissions were scanned and measured rotating the EUT to 360 degrees, varying cable placement and positioning the antenna 1 to 4 meters above the ground plane, in both the vertical and the horizontal polarization, to maximize the emission reading level.
- 3) Recorded at least the six highest emissions. Emission frequency, amplitude, antenna position, polarization and turntable position were recorded into a computer in which correction factors were used to calculate the emission level and compare reading to the applicable limit and only Q.P. reading is presented.
- 4) The test data of the worst case condition(s) was reported on the Summary Data page.

Data Sample:

Freq.	======== Raw Data	Corr. Factor	======= Emiss. Level	Limits	Margin	=====
(MHz)	(dBuV)	(dB)		ıV/m)	(dB)	
XX.XX	14.0	11.2	26.2	30	-3.8	

Freq. = Emission frequency in MHz

Raw Data (dBuV) = Uncorrected Analyzer / Receiver reading
Corr. Factor (dB) = Antenna factor + Cable loss – Amplifier gain
Emiss. Level (dBuV/m) = Raw reading converted to dBuV/m and CF added

Limit (dBuV/m) = Limit stated in standard
Margin (dB) = Reading in reference to limit

= Peak Reading

Q = Quasi-peak Reading A = Average Reading

Calculation example:

 $\begin{aligned} & Margin \ (dB) = Emiss. \ Level \ (dBuV/m) - Limits \ (dBuV/m) \\ & Emission \ Level \ (dBuV/m) = Raw \ Data \ (dBuV) + Corr \ Factor \ (dB) \end{aligned}$

RADIATED EMISSION LIMIT

Frequency (MHz)	Distance (m)	Maximum Field Strength Limit (dBu V/m/ Q.P.)
30-230	10	30
230-1000	10	37

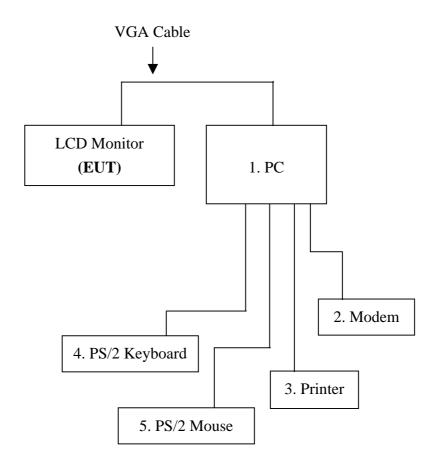
Note: The lower limit shall apply at the transition frequency.

10 BLOCK DIAGRAM OF TEST SETUP

System Diagram of Connections between EUT and Simulators

EUT: LCD Monitor

Trade Name: COMPAL
Model Number: GM678
Power Cord: Unshielded, 1.8m





11 SUMMARY DATA

(LINE CONDUCTED TEST)

Model Number: GM678 **Location:** Site # 3

Tested by: Hank Huang

Test Mode: Mode 1

Test Results: Passed

Temperature: 20°C **Humidity:** 65%RH

(The chart below shows the highest readings taken from the final data)

FREQ	Q.P.	AVG	Q.P.	AVG	Q.P.	AVG	NOTE
MHz	RAW	RAW	Limit	Limit	Margin	Margin	
	dBuV	dBuV	dBuV	dBuV	dB	dB	
0.155	41.00		65.70	55.70	-24.70		L1
2.301	32.40		56.00	46.00	-23.60		L1
2.433	30.20		56.00	46.00	-25.80		L1
17.448	31.60		60.00	50.00	-28.40		L1
18.369	34.00		60.00	50.00	-26.00		L1
19.350	31.40		60.00	50.00	-28.60		L1
0.155	42.30		65.70	55.70	-23.40		L2
2.172	32.10		56.00	46.00	-23.90		L2
2.435	31.00		56.00	46.00	-25.00		L2
6.307	26.50		60.00	50.00	-33.50		L2
9.150	26.20		60.00	50.00	-33.80		L2
25.843	25.70		60.00	50.00	-34.30		L2

L1 = Line One (Hot side) / L2 = Line Two (Neutral side)

^{**}NOTE: "---" denotes the emission level was or more than 2dB below the Average limit, so no re-check anymore.

SUMMARY DATA

(RADIATED EMISSION TEST)

Model Number: GM678 Location: Site # 1

Tested by: Hank Huang **Polar:** Vertical--10m

Test Mode: Mode 1 **Test Results:** Passed

Detector Function: Quasi-Peak

Temperature: 21°C **Humidity:** 65%RH

(The chart below shows the highest readings taken from the final data)

Freq.	Raw Data (dBuV)	Corr. Factor		Limits	Margin (dB)
(WIT1Z)	(uDu v)	(ub) 		·/III)	(ub)
78.75	15.5	6.8	22.3	30.0	-7.7
157.29	16.3	10.2	26.5	30.0	-3.5
168.08	15.1	10.5	25.6	30.0	-4.4
179.76	16.2	11.5	27.7	30.0	-2.3
200.80	12.2	10.8	23.0	30.0	-7.0
	18.1	16.2	34.3		-2.7
	7.5	22.3	29.8	37.0	-7.2
614.42	10.6	22.5	33.1	37.0	-3.9

SUMMARY DATA

(RADIATED EMISSION TEST)

Model Number: GM678 Location: Site # 1

Tested by: Hank Huang **Polar:** Horizontal--10m

Test Mode: Mode 1 **Test Results:** Passed

Detector Function: Quasi-Peak

Temperature: 21°C **Humidity:** 65%RH

(The chart below shows the highest readings taken from the final data)

Freq.	========= Raw Data	Corr. Factor		Limits	Margin
(MHz)	(dBuV)			V/m)	(dB)
	12.1	10.1			-7.8
189.54		11.2	20.8	30.0	-9.2
215.30	13.4	10.5	23.9	30.0	-6.1
	11.8			37.0	
501.60	8.4	21.2	29.6	37.0	-7.4
577.20	6.2	22.3	28.5	37.0	-8.5
	10.0			37.0	
	5.1	28.3			

12 SECTION 2 EN 61000-3-2 & EN 61000-3-3 (POWER HARMONICS & VOLTAGE FLUCTUATION / FLICKER)

POWER HARMONICS MEASUREMENT

Port : AC mains

Basic Standard : EN 61000-3-2 (1995 + A1: 1998 + A2: 1998)

Limits : $V \mid \text{CLASS A}$; $\square \text{CLASS D}$

Tester : Lung Tsai

Temperature : 25°C **Humidity** : 51%

VOLTAGE FLUCTUATION/FLICKER MEASUREMENT

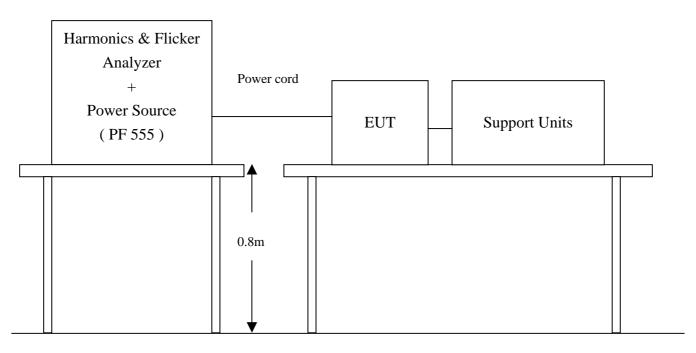
Port : AC mains

Basic Standard : EN 61000-3-3 (1995) **Limits** : § 5 of EN 61000-3-3

Tester : Lung Tsai **Temperature** : 25°C

Humidity : 51%

Block Diagram of Test Setup:



Result:

Please see the attached test data.

.....

EN 61000-3-2 TEST REPORT 2003/4/26 11:19 AM

Unit: LCD Monitor

Model No.: GM678

Remarks: Temp: 25°C Humid: 51%

Operator: Lung Tsai

TEST SETUP

Test Freq.: 50.00 Hz. Test Voltage: 230.0 vac Waveform: SINE Test Time: 2.5 min.

Classification: CLASS A Test Type: STEADY-STATE

Prog. Zo Enabled: YES Prog. Zo: 0.000

Motor Driven with Phase Angle Control: NO

Impedance selected: DIRECT

Synthetic R+L Enabled: NO

Resistance: 0.380 Ohms Inductance: 460.000 uH

MAX WATTS: 37.1W



TEST DATA

Result: PASS

Harmonic Current Results

Hn	AMPS	LO Limit	HI Limit	Result
0	0.000	0.000	0.000	PASS
1	0.162	NaN	NaN	PASS
2	0.001	1.080	1.080	PASS
3	0.134	2.300	2.300	PASS
4	0.001	0.430	0.430	PASS
5	0.121	1.140	1.140	PASS
6	0.001	0.300	0.300	PASS
7	0.109	0.770	0.770	PASS
8	0.001	0.230	0.230	PASS
9	0.094	0.400	0.400	PASS
10	0.001	0.184	0.184	PASS
11	0.078	0.330	0.330	PASS
12	0.001	0.153	0.153	PASS
13	0.061	0.210	0.210	PASS
14	0.001	0.131	0.131	PASS
15	0.044	0.150	0.150	PASS
16	0.000	0.115	0.115	PASS
17	0.029	0.132	0.132	PASS
18	0.000	0.102	0.102	PASS
19	0.017	0.118	0.118	PASS
20	0.000	0.092	0.092	PASS



21	0.009	0.107	0.107	PASS
22	0.000	0.084	0.084	PASS
23	0.008	0.098	0.098	PASS
24	0.000	0.077	0.077	PASS
25	0.011	0.090	0.090	PASS
26	0.000	0.071	0.071	PASS
27	0.012	0.083	0.083	PASS
28	0.000	0.066	0.066	PASS
29	0.011	0.078	0.078	PASS
30	0.000	0.061	0.061	PASS
31	0.010	0.073	0.073	PASS
32	0.000	0.058	0.058	PASS
33	0.007	0.068	0.068	PASS
34	0.000	0.054	0.054	PASS
35	0.004	0.064	0.064	PASS
36	0.000	0.051	0.051	PASS
37	0.002	0.061	0.061	PASS
38	0.000	0.048	0.048	PASS
39	0.003	0.058	0.058	PASS
40	0.000	0.046	0.046	PASS

END OF REPORT

EN 61000-3-3 TEST REPORT 2003/4/26 11:34 AM

Unit: LCD Monitor

Model No.: GM678 (Continue)

Remarks: Temp: 25°C Humid: 51%

Operator: Lung Tsai

TEST SETUP

Test Freq.: 50.00 Hz. Test Voltage: 230.0 vac

Waveform: SINE

Test Time: 10.0 min. Tshort: 10.0 min.

Prog. Zo Enabled: YES Prog. Zo: 0.000

Voltage Change less than once per Hour: NO

Impedance selected: DIRECT

Synthetic R+L Enabled: NO

Resistance: 0.380 Ohms Inductance: 460.000 uH

TEST DATA

Result: PASS

nabled
ue
ue
ue

END OF REPORT

EN 61000-3-3 TEST REPORT 2003/4/26 11: 47 PM

Unit: LCD Monitor

Model No.: GM678 (Manual Switch)

Remarks: Temp: 25°C Humid: 51%

Operator: Lung Tsai

TEST SETUP

Test Freq.: 50.00 Hz. Test Voltage: 230.0 vac

Waveform: SINE

Test Time: 10.0 min. Tshort: 10.0 min.

Prog. Zo Enabled: YES Prog. Zo: 0.000

Voltage Change less than once per Hour: NO

Impedance selected: DIRECT

Synthetic R+L Enabled: NO

Resistance: 0.380 Ohms Inductance: 460.000 uH

TEST DATA

Result: PASS

	EUT Data	Limit	Result	Test Enabled
Pst max	0.001	1.00	PASS	true
Plt max	0.001	0.65	PASS	true
dc %	0.00	3.00	PASS	true
dmax %	0.00	4.00	PASS	true
d(t) sec.	0.00	0.20	PASS	true
	Power Source Data			
Source Pst max	0.020	0.400	PASS	true
% THD	0.03	3.00	PASS	true

END OF REPORT

13 SECTION 3 IEC 61000-4-2 (ELECTROSTATIC DISCHARGE)

ELECTROSTATIC DISCHARGE (ESD) IMMUNITY TEST

Port : Enclosure

Basic Standard: IEC 61000-4-2

Test Level : $\pm 8 \text{ kV (Air Discharge)}$

± 4 kV (Contact Discharge) ± 4 kV (Indirect Discharge)

Performance Criteria: B (Standard Require)

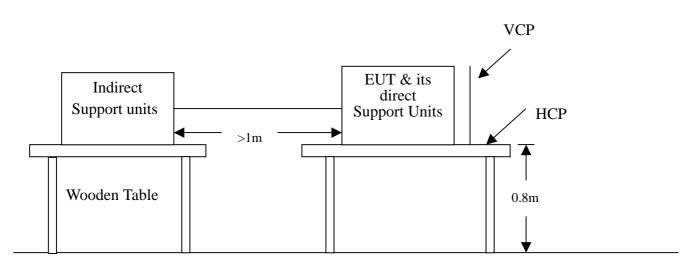
Tester : Lung Tsai **Temperature** : 23°C

Humidity : 46%

Pressure : 1018mbar

Block Diagram of Test Setup:

(The 470 k ohm resistors are installed per standard requirement)



Ground Reference Plane



Test Procedure:

- 1. The EUT was located 0.1 m minimum from all side of the HCP.
- 2. The indirect support units were located 1 m minimum away from the EUT, but direct support unit was/were located at same location as EUT on the HCP and keep at a distance of 10 cm with EUT.
- 3. A scroll 'H' test program was loaded and executed in Windows 98 mode.
- 4. The Host PC sent above message to EUT and related peripherals through the test.
- 5. Active the communication function if the EUT with such port(s).
- 6. As per the requirement of EN 55024; applying direct contact discharge at the sides other than front of EUT at minimum 50 discharges (25 positive and 25 negative) if applicable, can't be applied direct contact discharge side of EUT then the indirect discharge shall be applied. One of the test points shall be subjected to at least 50 indirect discharge (contact) to the front edge of horizontal coupling plane.
- 7. Other parts of EUT where it is not possible to perform contact discharge then selecting appropriate points of EUT for air discharge, a minimum of 10 single air discharges shall be applied.
- 8. The application of ESD to the contact of open connectors is not required.
- 9. The EUT direct connection units also need to be applied ESD at the port of EUT cable connected.
- 10. Putting a mark on EUT to show tested points. The following test condition was followed during the tests.

Note: As per IEC 61000-4-2:2001, with two 470k bleed resistors cable is connected between the EUT and HCP during the test applicable for power ungrounded or battery operating unit only.

The electrostatic discharges were applied as follows:

Amount of Discharges	Voltage	Coupling	Result (Pass/Fail)
Mini 10 /Point	$\pm 8 \text{ kV}$	Air Discharge	Pass
Mini 25 /Point	$\pm 4 \text{ kV}$	Contact Discharge	Pass
Mini 25 /Point	± 4 kV	Indirect Discharge HCP (Front)	Pass
Mini 25 /Point	± 4 kV	Indirect Discharge VCP (Right)	Pass
Mini 25 /Point	± 4 kV	Indirect Discharge VCP (Left)	Pass
Mini 25 /Point	± 4 kV	Indirect Discharge VCP (Back)	N/A

^{**}The tested points to EUT, please refer to attached page.

(Blue arrow mark for Contact Discharge and red arrow mark for Air Discharge)

Performance & Result:

V Criteria A:	The apparatus continues to operate as intended.	No degradation of performance
	or loss of function is allowed below a performance	e level specified by the
	manufacturer, when the apparatus is used as intended	ded. In some cases the

	manufacturer, when the apparatus is used as intended. In some cases the performance level may be replaced by a permissible loss of performance.
Criteria B:	The apparatus continues to operate as intended after the test. No degradation of
	performance or loss of function is allowed below a performance level specified
	by the manufacturer, when the apparatus is used as intended. In some cases the
	performance level may be replaced by a permissible loss of performance.
.	During the test, degradation of performance is however allowed.
Criteria C:	Temporary loss of function is allowed, provided the functions self recoverable or

Observation: No any function	
V PASS	☐ FAILED
can be restored by the operation	a of controls.



The Tested Points of EUT

Photo 1 of 2



Photo 2 of 2



14 SECTION 4 IEC 61000-4-3 (RADIATED ELECTROMAGNETIC FIELD)

RADIATED ELECTROMAGNETIC FIELD IMMUNITY TEST

Port : Enclosure

Basic Standard: IEC 61000-4-3

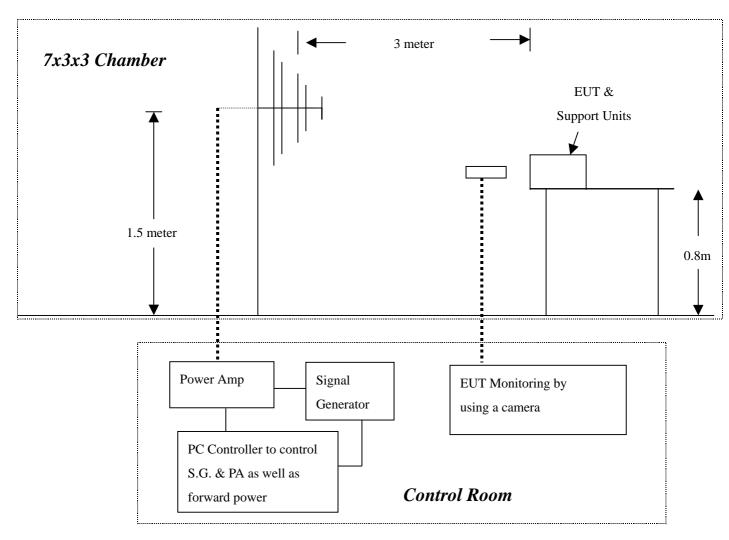
Requirements : 3 V/m / with 80% AM. 1kHz Modulation.

Performance Criteria: A (Standard Require)

Tester : Lung Tsai
Temperature : 23°C
Humidity : 46%

Pressure: 1018mbar

Block Diagram of Test Setup:





Test Procedure:

- 1. The EUT was located at the edge of supporting table keep 3 meter away from transmitting antenna, it just the calibrated square area of field uniformity. The support units were located outside of the uniformity area, but the cable(s) connected with EUT were exposed to the calibrated field as per IEC 61000-4-3.
- 2. A scroll 'H' messages were displayed on part of screen of EUT and an enlarged 'H' characters were displayed on the other part of screen of EUT.
- 3. Adjusting the monitoring camera to monitor the 'H' message as clear as possible.
- 4. Setting the testing parameters of RS test software per IEC 61000-4-3.
- 5. Performing the pre-test at each side of with double specified level (6V/m) at 4% steps.
- 6. From the result of pre-test in step 5, choice the worst side of EUT for final test from 80 MHz to 1000 MHz at 1% steps.
- 7. Recording the test result in following table.
- 8. It is not necessary to perform test as per annex A of EN 55024 if the EUT doesn't belong to ITE product.

IEC 61000-4-3 Preliminary test conditions:

Test level : 6V/m

Steps : 4 % of fundamental

Dwell Time : 3 sec

Range (MHz)	Field	Modulation	Polarity	Position (°)	Result (Pass/Fail)
80-1000	6V/m	Yes	Н	Front	Pass
80-1000	6V/m	Yes	V	Front	Pass
80-1000	6V/m	Yes	Н	Right	Pass
80-1000	6V/m	Yes	V	Right	Pass
80-1000	6V/m	Yes	Н	Back	Pass
80-1000	6V/m	Yes	V	Back	Pass
80-1000	6V/m	Yes	Н	Left	Pass
80-1000	6V/m	Yes	V	Left	Pass

IEC 61000-4-3 Final test conditions:

Test level : 3V/m

Steps : 1 % of fundamental

Dwell Time : 3 sec

Range (MHz)	Field	Modulation	Polarity	Position (°)	Result (Pass/Fail)
80-1000	3V/m	Yes	Н	Back	Pass
80-1000	3V/m	Yes	V	Back	Pass



Performance & Result:

V	Criteria A:	The apparatus continues to operate as intended. No degradation of performance or loss of function is allowed below a performance level specified by the manufacturer, when the apparatus is used as intended. In some cases the performance level may be replaced by a permissible loss of performance.			
	Criteria B:				
	Criteria C:	Temporary loss of function is allowed, provided the functions self recoverable or can be restored by the operation of controls.			
		V PASS FAILED			
	Observat	ion: No any function degraded during the tests.			

15 SECTION 5 IEC 61000-4-4 (FAST TRANSIENTS/BURST)

FAST TRANSIENTS/BURST IMMUNITY TEST

Port : On Power Supply Lines

Basic Standard: IEC 61000-4-4

Requirements : $\pm 1 \text{ kV}$ for Power Supply Line

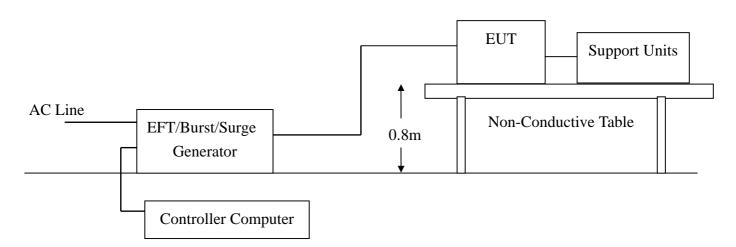
Performance Criteria: B (Standard Require)

Tester : Lung Tsai

Temperature : 23°C **Humidity** : 46%

Pressure : 1018mbar

Block Diagram of Test Setup:





Test Procedure:

- 1. The EUT and support units were located on a wooden table 0.8 m away from ground reference plane.
- 2. A 1.0 meter long power cord was attached to EUT during the test.
- 3. The length of communication cable between communication port and clamp was keeping within 1 meter.
- 4. A test program was loaded and executed in Windows 98 mode.
- 5. The data was sent to EUT filling the screens with upper case of "H" patterns.
- 6. The test program exercised related support units sequentially.
- 7. Repeating step 3 to 6 through the test and increase test voltage to the EUT ports from minimum to standard request or client request.
- 8. Recording the test result as shown in following table.

Test conditions:

Impulse Frequency: 5kHz
Tr/Th: 5/50ns
Burst Duration: 15ms
Burst Period: 3Hz

Buist 1 chod . 3112			
Inject Line	Voltage kV	Inject Method	Result (Pass/Fail)
L	± 1	Direct	Pass
N	± 1	Direct	Pass
PE	± 1	Direct	Pass
L+N	± 1	Direct	Pass
L + PE	± 1	Direct	Pass
N + PE	± 1	Direct	Pass
L1 + N + PE	+ 1	Direct	Pass

Performance & Result:

$oldsymbol{V}$	Critoria A	The apparatus continues to operate as intended. No degradation of performance		
,	Cincia A.	or loss of function is allowed below a performance level specified by the manufacturer, when the apparatus is used as intended. In some cases the performance level may be replaced by a permissible loss of performance.		
	Criteria B:	The apparatus continues to operate as intended after the test. No degradation of performance or loss of function is allowed below a performance level specified by the manufacturer, when the apparatus is used as intended. In some cases the performance level may be replaced by a permissible loss of performance. During the test, degradation of performance is however allowed.		
	Criteria C:	Temporary loss of function is allowed, provided the functions self recoverable or can be restored by the operation of controls.		
		V PASS FAILED		
Observation: No any function degraded during the tests.				

16 SECTION 6 IEC 61000-4-5 (SURGE IMMUNITY)

SURGE IMMUNITY TEST

Port : Power Cord

Basic Standard : IEC 61000-4-5

Requirements : $\pm 1 \text{ kV}$ (Line to Line)

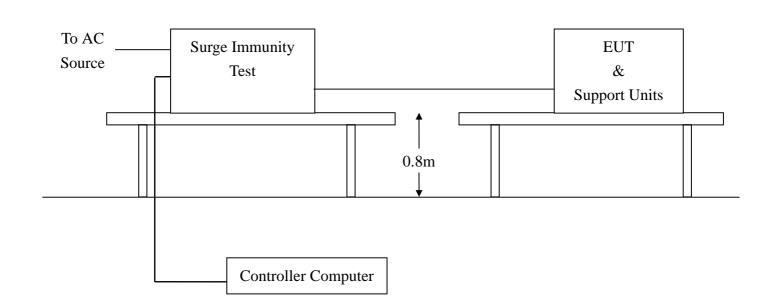
± 2 kV (Line to Ground)

Performance Criteria: B (Standard Require)

Tester: Lung TsaiTemperature: 23°CHumidity: 46%

Pressure : 1018mbar

Block Diagram of Test Setup:





Test Procedure:

- 1. The EUT and support units were located on a wooden table 0.8 m away from ground floor.
- 2. A test program was loaded and executed in Windows 98 mode.
- 3. The data was sent to EUT filling the screens with upper case of "H" patterns.
- 4. The test program exercised related support units sequentially.
- 5. Repeating step 3 to 4 through the test and increase test voltage to the EUT ports from minimum to standard request or client request.
- 6. Recording the test result as shown in following table.

Test conditions:

Voltage Waveform : 1.2/50 us Current Waveform : 8/20 us

Polarity : Positive/Negative Phase angle : 0°, 90°, 270°

Number of Test : 5

Coupling Line	Voltage (kV)	Polarity	Coupling Method	Result (Pass/Fail)
L1-L2	1	Positive	Capacitive	Pass
L1-PE	2	Positive	Capacitive	Pass
L2-PE	2	Positive	Capacitive	Pass
L1-L2	1	Negative	Capacitive	Pass
L1-PE	2	Negative	Capacitive	Pass
L2-PE	2	Negative	Capacitive	Pass

Performance & Result:

17	O A .				
<u>v</u> (Criteria A:	The apparatus continues to operate as intended. No degradation of performance or loss of function is allowed below a performance level specified by the			
		manufacturer, when the apparatus is used as intended. In some cases the			
		performance level may be replaced by a permissible loss of performance.			
	Criteria B:	The apparatus continues to operate as intended after the test. No degradation of			
		performance or loss of function is allowed below a performance level specified			
		by the manufacturer, when the apparatus is used as intended. In some cases the			
		performance level may be replaced by a permissible loss of performance.			
		During the test, degradation of performance is however allowed.			
(Criteria C:	Temporary loss of function is allowed, provided the functions self recoverable or			
	can be restored by the operation of controls.				
	V PASS FAILED				
O	Observation: No any function degraded during the tests.				

17 SECTION 7 IEC 61000-4-6 (CONDUCTED DISTRBANCE/INDUCED RADIO-FREQUENCY FIELD)

CONDUCTED DISTRBANCE/INDUCED RADIO-FREQUENCY FIELD IMMUNITY TEST

Port : AC Port

Basic Standard: IEC 61000-4-6

Requirements : 3 V / with 80% AM. 1kHz Modulation.

Injection Method : CDN-M3

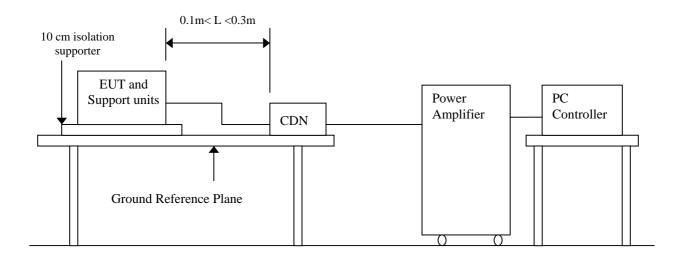
Performance Criteria: A (Standard Require)

Tester : Lung Tsai

Temperature : 23°C **Humidity** : 46%

Pressure : 1018mbar

Block Diagram of Test Setup:





Test Procedure:

- 1. The EUT and support units were located at a ground reference plane with the interposition of a 0.1 m thickness insulating support and the CDN was located on GRP directly.
- 2. A 'H' messages were displayed on screen of EUT.
- 3. Adjusting the monitoring camera to monitor the 'H' message as clear as possible.
- 4. Setting the testing parameters of CS test software per IEC 61000-4-6.
- 5. Recording the test result in following table.

Test conditions:

Frequency Range : 0.15MHz-80MHz
Frequency Step : 1% of fundamental

Dwell Time : 3 sec

Range (MHz)	Field	Modulation	Result (Pass/Fail)
0.15-80	3V	Yes	Pass

Performance & Result:

V	Criteria A:	The apparatus continues to operate as intended. No degradation of performance or loss of function is allowed below a performance level specified by the			
		manufacturer, when the apparatus is used as intended. In some cases the performance level may be replaced by a permissible loss of performance.			
	Criteria B:	The apparatus continues to operate as intended after the test. No degradation of performance or loss of function is allowed below a performance level specified by the manufacturer, when the apparatus is used as intended. In some cases the performance level may be replaced by a permissible loss of performance. During the test, degradation of performance is however allowed.			
	Criteria C:	Temporary loss of function is allowed, provided the functions self recoverable or can be restored by the operation of controls.			
		V PASS FAILED			
	Observation: No any function degraded during the tests.				

18 SECTION 8 IEC 61000-4-8 (POWER FREQUENCY MAGNETIC FIELD IMMUNITY TEST)

POWER FREQUENCY MAGNETIC FIELD IMMUNITY TEST

Port : Enclosure

Basic Standard: IEC 61000-4-8

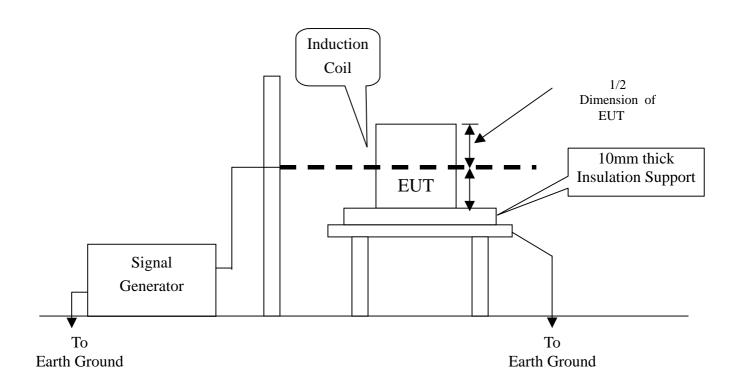
Requirements : 1 A/m

Performance Criteria: A (Standard Require)

Tester : Lung Tsai
Temperature : 23°C
Humidity : 46%

Pressure : 1018mbar

Block Diagram of Test Setup:





Test Procedure:

- 1. The EUT and support units were located on Ground Reference Plane with the interposition of a 0.1 m thickness insulation support.
- 2. Putting the induction coil on horizontal direction.(X direction)
- 3. A test program was loaded and executed in Windows 98 mode.
- 4. The data was sent to the screen of EUT and filling the screen with upper case of "H" patterns.
- 5. The test program exercised related support units sequentially.
- 6. Repeating step 3 to 5 through the test.
- 7. Recording the test result as shown in following table.
- 8. Rotating the induction coil by 90° (Y direction) then repeat step 3 to 7.
- 9. Rotating the induction coil by 90° again (Z direction) then repeat step 3 to 7.
- *. Test conditions:

Field Strength: 1A/m Power Freq.: 50Hz Orientation: X, Y, Z

Orientation	Field	Result (Pass/Fail)	Remark
X	1A/m	Pass	
Y	1A/m	Pass	
Z	1A/m	Pass	

Performance & Result:

V Criteria A:	The apparatus continues to operate as intended. No degradation of performance or loss of function is allowed below a performance level specified by the manufacturer, when the apparatus is used as intended. In some cases the performance level may be replaced by a permissible loss of performance.				
Criteria B:	The apparatus continues to operate as intended after the test. No degradation performance or loss of function is allowed below a performance level specified by the manufacturer, when the apparatus is used as intended. In some cases to performance level may be replaced by a permissible loss of performance. During the test, degradation of performance is however allowed.				
Criteria C:	Temporary loss of function is allowed, provided the functions self recoverable or can be restored by the operation of controls.				
	V PASS FAILED				
Observat	tion: No any function degraded during the test.				



19 SECTION 9 IEC 61000-4-11 (VOLTAGE DIPS, SHORT INTERRUPTIONS AND VOLTAGE VARIATIONS)

VOLTAGE DIPS / SHORT INTERRUPTIONS

Port : AC mains

Basic Standard : IEC 61000-4-11 (1994)

Requirement : PHASE ANGLE 0, 45, 90, 135, 180, 225, 270, 315 degrees

	Test Level	Reduction	Duration	Performance
Voltage	% U _T	(%)	(periods)	Criteria
Dips	<5	>95	0.5	В
	70	30	25	С

Valtage	Test Level	Reduction	Duration	Performance
Voltage	% U _T	(%)	(periods)	Criteria
Interceptions	<5	>95	250	С

Test Interval : Min. 10 sec.

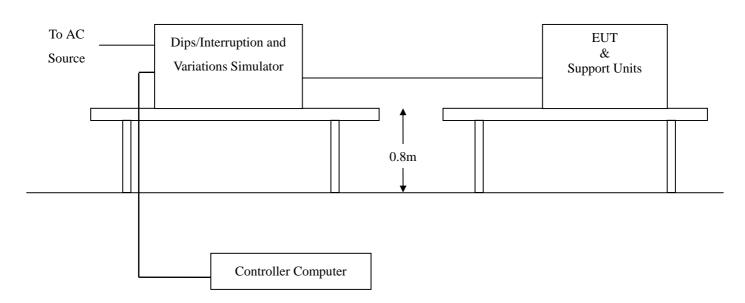
Tester : Lung Tsai

Temperature : 23°C

Humidity : 46%

Pressure : 1018mbar

Block Diagram of Test Setup:





Test Procedure:

- 1. The EUT and support units were located on a wooden table, 0.8 m away from ground floor.
- 2. A test program was loaded and executed in Windows 98 mode.
- 3. The data was sent to EUT filling the screens with upper case of "H" patterns.
- 4. The test program exercised related support units sequentially.
- 5. Setting the parameter of tests and then Perform the test software of test simulator.
- 6. Conditions changes to occur at 0 degree crossover point of the voltage waveform.
- 7. Repeating step 3 to 4 through the test.
- 8. Recording the test result in test record form.

Test conditions:

The duration with a sequence of three dips/interruptions with interval of 10 s minimum (Between each test event)

Voltage Dips:

Test Level % U _T	Reduction (%)	Duration (periods)	Observation	Meet Performance Criteria
0	100	0.5	Normal	A
70	30	25	Normal	A

Voltage Interruptions:

vottage interruptions.				
Test Level % U _T	Reduction (%)	Duration (periods)	Observation	Meet Performance Criteria
0	100	250	EUT shut down, but can	В
			be auto recovered as the	
			events disappear.	

Normal: No any functions degrade during and after the test.

Performance & Result:

Criteria A: The apparatus continues to operate as intended. No degradation of performance or loss of function is allowed below a performance level specified by the

manufacturer, when the apparatus is used as intended. In some cases the performance level may be replaced by a permissible loss of performance.

Criteria B: The apparatus continues to operate as intended after the test. No degradation of

performance or loss of function is allowed below a performance level specified by the manufacturer, when the apparatus is used as intended. In some cases the performance level may be replaced by a permissible loss of performance.

During the test, degradation of performance is however allowed.

Criteria C: Temporary loss of function is allowed, provided the functions self recoverable or can be restored by the operation of controls.

20 APPENDIX 1 PHOTOGRAPHS OF TEST SETUP

20.1 LINE CONDUCTED EMISSION TEST (EN 55022)

Front View



Back View





20.2 RADIATED EMISSION TEST (EN 55022)

Front View



Back View



20.3 POWER HARMONIC & VOLTAGE FLUCTUATION / FLICKER TEST

(EN 61000-3-2, EN 61000-3-3)



ILAC MRA

20.4 ELECTROSTATIC DISCHARGE TEST (IEC 61000-4-2)





20.5 RADIATED ELECTROMAGNETIC FIELD (IEC 61000-4-3)



20.6 FAST TRANSIENTS/BURST TEST (IEC 61000-4-4)



20.7 SURGE IMMUNITY TEST (IEC 61000-4-5)



20.8 CONDUCTED DISTURBANCE, INDUCED BY RADIO-FREQUENCY FIELDS TEST (IEC 61000-4-6)



20.9 POWER FREQUENCY MAGNETIC FIELD IMMUNITY TEST (IEC 61000-4-8)



20.10 VOLTAGE DIPS / INTERRUPTION TEST (IEC 61000-4-11)



21 APPENDIX 2 PHOTOGRAPHS OF EUT



Front View of EUT



Back View of EUT





Left View of EUT



Right View of EUT





I/O Port of EUT

